


<b>Search Notes</b>  	<b>Application/Control No.</b>  10586798	<b>Applicant(s)/Patent Under Reexamination</b>  KANEKO ET AL.
	<b>Examiner</b>  shih-wen hsieh	<b>Art Unit</b>  2861

SEARCHED			
Class	Subclass	Date	Examiner
347	updated	2-12-09	SWH

SEARCH NOTES		
Search Notes	Date	Examiner
east text search	2-12-09	SWH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
347	22,29,32,33,104	2-12-09	SWH

	/shih-wen hsieh/ Primary Examiner.Art Unit 2861
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